

**Search Notes**

Application/Control No.

10/802,887

Examiner

Mark A. Chapman

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	109.4	5/9/2006	MC
	137.17		
	108.3		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	5/9/2006	MC